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#4/A  
10 Jul 02  
R. Tallor

APPLICANT: Mailaender et al.

SERIAL No. Unassigned

EXAMINER: Unassigned

FILED: Herewith

GROUP No.: Unassigned

TITLE: TESTING ARRANGEMENT FOR OPTICAL DEVICES

Attorney Docket No.: 20 01 1067

Box Patent Application  
Commissioner for Patents  
Washington, D.C. 20231

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February 8, 2002 (Date of Deposit).

Allison Berkman

Name

*Allison Berkman*

Signature

**PRELIMINARY AMENDMENT**

Dear Sir:

Please amend the application as follows:

In The Abstract

Please amend the abstract as follows:

A<sup>1</sup>  
A measuring setup for measuring an optical device under test – DUT- includes an optical signal source for applying an optical signal to the DUT, and an optical receiver unit for measuring a response of the DUT on the applied signal. A measurement unit is coupled between the optical signal source and the optical receiver unit. The measurement unit comprises an optical circuit to provide optical signals from and/or to the DUT for measuring the DUT, whereby the optical circuit comprises optical components showing high susceptibility to mechanical noise. A shielding unit receives the optical circuit and provides at